Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/632,499	OLSCHEWSKI, FRANK	
Examiner	Art Unit	
Dennis Rosario	2624	

	SEARCHED .					
Class	Subclass	Date	Examiner			
382	107	114107	DL			
348	(103) 169-17 ₀	(2/21/07)	() ¹ / ₂)			
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(vpdated) (Fast, all dB)	1/4/07 3/21/07)	DR (DP)		
IEEE-trajectory (near) pixel and filter#-	115102	DR		
TEEE-optical Knew/flow and pixel and Ctraged o-Frack*)-	न्द १४।०७	DR		
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